

<b>Notice of References Cited</b>	Application/Control No. 10/761,258		Applicant(s)/Patent Under Reexamination YOSHIDA ET AL.	
	Examiner Paul A. Wartalowicz		Art Unit 1754	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0012628	01-2002	Sawabe et al.	423/610
	C	US-			
	D	US-			
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	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	EP 279643	07-2002	EP	Sakatani et al.	C01G 23/053
	O	2003-096433				
	P	2001-72419	03-2001	JP	Sakatani et al.	C 01 G 23/053
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	U	Machine Translation of JP 2003-096433
	V	Machine Translation of JP 2001-72419
	W	Machine Translation of 2001-278625
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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